Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/646,468	KOBREHEL ET AL.	
Examiner	Art Unit	
Phi D. A	3637	

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Class	Subclass	Date	Examiner
52	204.599	4/1/2006	PA
	204.593	1	1
	204.69		
	204.71		
	786.11	1/	
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INI	ERFERENC	ICE SEARCHED		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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